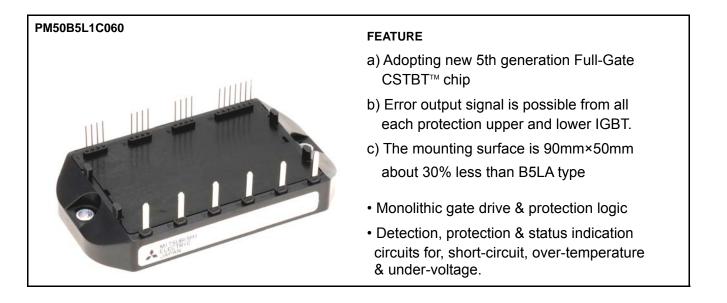
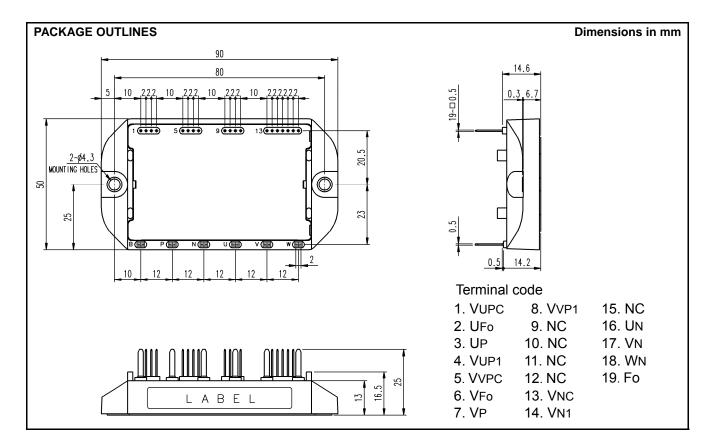
FLAT-BASE TYPE INSULATED PACKAGE



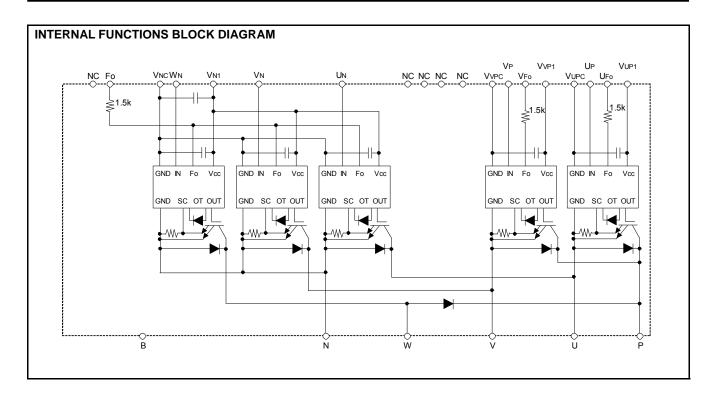
APPLICATION

Photo voltaic power conditioner





FLAT-BASE TYPE INSULATED PACKAGE



MAXIMUM RATINGS (T_j = 25°C, unless otherwise noted)

INVERTER PART

Symbol	Parameter	Conditions	Ratings	Unit
V _{CES}	Collector-Emitter Voltage	V _D =15V, V _{CIN} =15V	600	V
lc	Collector Current	T _c =25°C	50	Α
I _{CRM}	Collector Current	Pulse	100	
P _{tot}	Total Power Dissipation	T _c =25°C	168	W
I _E	Emitter Current	T _c =25°C	50	٨
I _{ERM}	(Free wheeling Diode Forward current)	Pulse	100	A
Tj	Junction Temperature		-20 ~ +150	°C

*: Tc measurement point is just under the chip.

CONVERTER PART

Symbol	Parameter	Conditions	Ratings	Unit
V _{CES}	Collector-Emitter Voltage	V _D =15V, V _{CIN} =15V	600	V
I _C	Collector Current	T _c =25°C	50	А
I _{CRM}		Pulse	100	^
P _{tot}	Total Power Dissipation	T _c =25°C	168	W
I _E	Emitter Current	T _c =25°C	50	Α
I _{ERM}	(Free wheeling Diode Forward current)	Pulse	100	
l _F	Di Forward Current	T _c =25°C	50	Α
V _{R(DC)}	Di Rated DC Reverse Voltage	T _c =25°C	600	V
Tj	Junction Temperature		-20 ~ +150	°C

*: Tc measurement point is just under the chip.



FLAT-BASE TYPE INSULATED PACKAGE

CONTROL PART

Symbol	Parameter	Conditions	Ratings	Unit
VD	Supply Voltage	Applied between : V_{UP1} - V_{UPC} , V_{VP1} - V_{VPC} , V_{N1} - V_{NC}	20	V
V _{CIN}	Input Voltage	Applied between : UP-V _{UPC} , VP-V _{VPC} , UN·VN·WN -V _{NC}	20	V
V _{FO}	Fault Output Supply Voltage	Applied between : UFo-V _{UPC} , VFo-V _{VPC} , Fo-V _{NC}	20	V
I _{FO}	Fault Output Current	Sink current at UFo, VFo, Fo terminals	20	mA

TOTAL SYSTEM

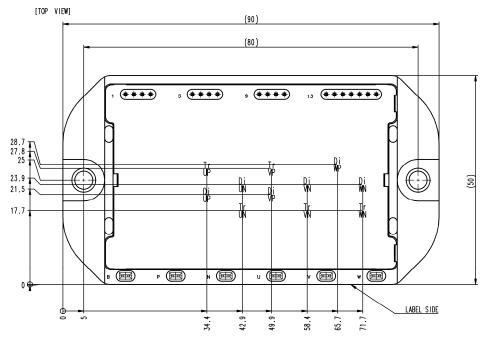
Symbol	Parameter	Conditions	Ratings	Unit
V _{CC(PROT)}	Supply Voltage Protected by SC	$V_D = 13.5V \sim 16.5V$ Inverter Part, T _i =+125°C Start	450	V
V _{CC(surge)}	Supply Voltage (Surge)	Applied between : P-N, Surge value	500	V
T _{stg}	Storage Temperature		-40 ~ +125	°C
V _{isol}	Isolation Voltage	60Hz, Sinusoidal, Charged part to Base plate, AC 1min, RMS	2500	V

*: T_{C} measurement point is just under the chip.

THERMAL RESISTANCE

Symbol	Parameter	Conditions		Limits			Unit
Symbol Farameter		Conditions		Min.	Тур.	Max.	Onic
R _{th(j-c)Q}	Thermal Resistance	Inverter, IGBT (per 1 element)	(Note.1)	-	-	0.74	
R _{th(j-c)D}		Inverter, FWDi (per 1 element)	(Note.1)	-	-	1.28	
R _{th(j-c)Q}		Converter, IGBT (per 1 element)	(Note.1)	-	-	0.74	
R _{th(j-c)D}		Converter, FWDi (per 1 element)	(Note.1)	-	-	1.28	K/W
R _{th(j-c)D}		Converter, Di (per 1 element)	(Note.1)	-	-	1.28	
R _{th(c-s)}	Contact Thermal Resistance	Case to heat sink, (per 1 module) Thermal grease applied	(Note.1)	-	0.06	-	

Note.1: If you use this value, $R_{th(s-a)}$ should be measured just under the chips.





FLAT-BASE TYPE INSULATED PACKAGE

ELECTRICAL CHARACTERISTICS (Tj = 25°C, unless otherwise noted) **INVERTER PART**

Symbol	Parameter	Conditions		Limits			Unit
Symbol	Falameter	Conditions		Min.	Тур.	Max.	Unit
V _{CEsat}	Collector-Emitter Saturation	V _D =15V, I _C =50A	T _j =25°C	-	2.2	2.7	V
V CEsat	Voltage	V _{CIN} =0V, Pulsed (Fig. 1)	T _j =125°C	-	2.2	2.7	v
V _{EC}	Emitter-Collector Voltage	I _E =50A, V _D =15V, V _{CIN} = 15V	(Fig. 2)	-	2.4	3.3	V
t _{on}				0.1	0.5	1.2	
t _{rr}		V _D =15V, V _{CIN} =0V↔15V		-	0.1	0.2	
t _{c(on)}	Switching Time	V _{cc} =300V, I _c =50A T _i =125°C		-	0.15	0.3	μs
t _{off}		Inductive Load (Fig. 3,4)	(Fig. 3.4)	-	1.1	2.0	
t _{c(off)}			(**3**,*)	-	0.2	0.4	
1	Collector-Emitter Cut-off Current V _{CE} =V _{CES} , V _D =15V , V _{CIN} =15V (F	$(-1)^{-1}$	Tj=25°C	-	-	1	mA
I _{CES}		$v_{CE} - v_{CES}, v_D - 15v, v_{CIN} = 15v (FIg. 5)$	T _j =125°C	-	-	10	IIIA

CONVERTER PART

Symbol	Parameter	Conditions		Limits			Unit	
Symbol	Faiametei	Conditio	5115		Min.	Тур.	Max.	Onit
V _{CEsat}	Collector-Emitter Saturation	V _D =15V, I _C =50A		T _j =25°C	-	2.2	2.7	v
V CEsat	Voltage	V _{CIN} =0V, Pulsed (F	⁻ ig. 1)	T _j =125°C	-	2.2	2.7	v
V _{EC}	Emitter-Collector Voltage	I _E =50A, V _D =15V, V _{CIN} = 15V		(Fig. 2)	-	2.4	3.3	V
V _{FM}	Di Forward Voltage	I _F =50A			-	2.4	3.3	V
t _{on}					0.1	0.5	1.2	
t _{rr}		$V_D=15V, V_{CIN}=0V \leftrightarrow 15V$			-	0.1	0.2	
t _{c(on)}	Switching Time	V _{CC} =300V, I _C =50A T _i =125°C			-	0.15	0.3	μS
t _{off}		Inductive Load		(Fig. 3,4)	-	1.1	2.0	
t _{c(off)}				(g. e, .)	-	0.2	0.4	
	Collector-Emitter Cut-off Current	$V_{CE}=V_{CES}, V_{D}=15V, V_{CIN}=15V$ (Fig. 5)	T _j =25°C	-	-	1	mA	
I _{CES}			T _j =125°C	-	-	10	ША	

CONTROL PART

Symbol	Parameter	Parameter Conditions -			Unit		
Symbol	Faiallietei			Min.	Тур.	Max.	Unit
1	Circuit Current	V _D =15V, V _{CIN} =15V	V _{N1} -V _{NC}	-	6.5	12	mA
I _D	Circuit Current	$v_{\rm D}$ = 15v, $v_{\rm CIN}$ = 15v	V*P1-V*PC	-	1.6	4.0	mA
V _{th(ON)}	Input ON Threshold Voltage	Applied between : UP-V _{UPC} , VP-V _{VPC} ,	Un · Vn · Wn -V _{nc}	1.2	1.5	1.8	v
$V_{th(OFF)}$	Input OFF Threshold Voltage			1.7	2.0	2.3	v
SC	Short Circuit Trip Level	-20≤Tj≤125°C, V _D =15V	(Fig. 3, 6)	75	-	-	Α
$t_{\text{off}(\text{SC})}$	Short Circuit Current Delay Time	V _D =15V	(Fig. 3, 6)	-	0.2	-	μs
OT	Over Temperature Drotestion	Detect Temperature of ICBT chin	Trip level	135	-	-	- °C
OT _(hys)	Over Temperature Protection	Detect Temperature of IGBT chip	Hysteresis	-	20	-	
UVt	Supply Circuit Under-Voltage	-20≤Ti≤125°C	Trip level	11.5	12.0	12.5	v
UVr	Protection	-205135125 C	Reset level	-	12.5	-	v
I _{FO(H)}	Fault Output Current		(Noto 2)	-	-	0.01	m۸
I _{FO(L)}	 Fault Output Current 	V _D =15V, V _{FO} =15V	(Note.2)	-	10	15	mA
t _{FO}	Fault Output Pulse Width	V _D =15V	(Note.2)	1.0	1.8	-	ms

Note.2: Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.



FLAT-BASE TYPE INSULATED PACKAGE

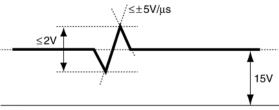
MECHANICAL RATINGS AND CHARACTERISTICS

Symbol Pa	Parameter	Conditions		Limits		
	Farameter	Conditions	Min.	Тур.	Max.	Unit
Ms	Mounting Torque	Mounting part screw : M4	1.4	1.65	1.9	N∙m
m	Weight	-	-	135	-	g

RECOMMENDED CONDITIONS FOR USE

Symbol	Parameter	Conditions	Recommended value	Unit
V _{CC}	Supply Voltage	Applied across P-N terminals	≤ 450	V
V _D	Control Supply Voltage	$\begin{array}{c} \mbox{Applied between : } V_{UP1} - V_{UPC}, \\ V_{VP1} - V_{VPC}, V_{N1} - V_{NC} \end{array} (Note.3) \end{array}$	15.0±1.5	V
V _{CIN(ON)}	Input ON Voltage	Applied between : UP-V _{UPC} , VP-V _{VPC} , UN·VN·WN -V _{NC}	≤ 0.8	V
$V_{\text{CIN}(\text{OFF})}$	Input OFF Voltage		≥ 9.0	v
f _{PWM}	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
\mathbf{t}_{dead}	Arm Shoot-through Blocking Time	For IPM's each input signals (Fig. 7)	≥ 2.0	μS
lo	Module Operating Current	RMS	≤ 20	Α

Note.3: With ripple satisfying the following conditions: dv/dt swing $\leq \pm 5V/\mu s$, Variation $\leq 2V$ peak to peak



GND



VCE

10%

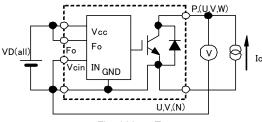
90%

(toff = td(off) + tf)

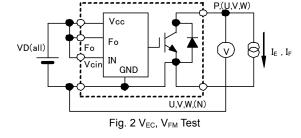
PRECAUTIONS FOR TESTING

- 1. Before applying any control supply voltage (V_D), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state.
- After this, the specified ON and OFF level setting for each input signal should be done.
- 2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above V_{CES} rating of the device.

(These test should not be done by using a curve tracer or its equivalent.)







lc

10%

td(off)

Fig. 4 Switching time test waveform

tc(off)

Irr

90%

(ton = td(on) + tr)

10%

tc(on)

V_{CIN}

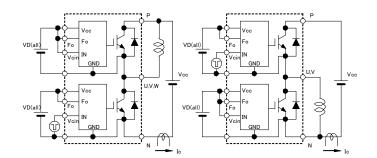
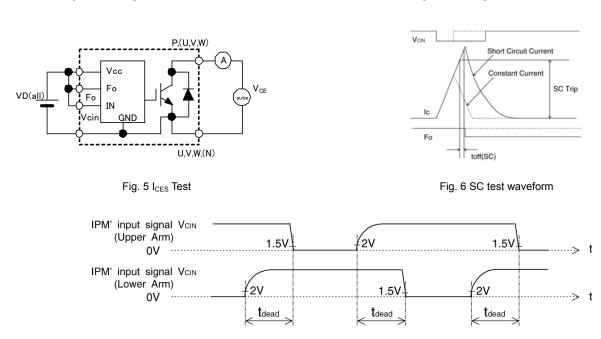


Fig. 3 Switching time and SC test circuit

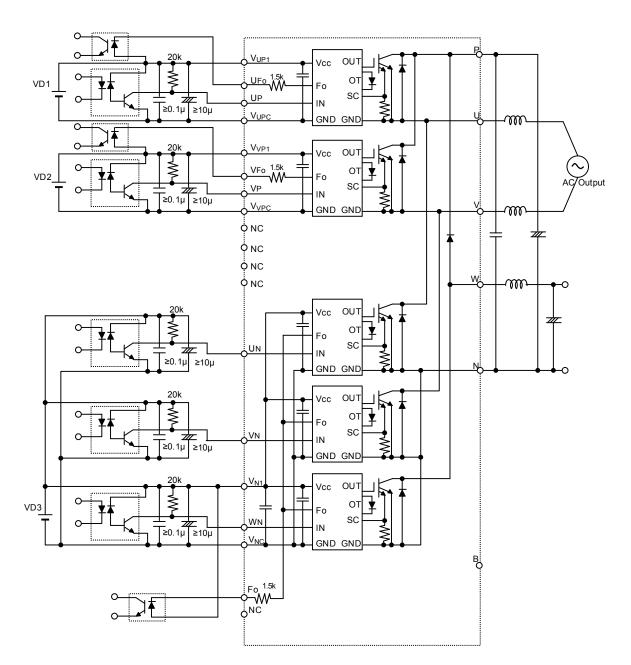


1.5V: Input on threshold voltage Vth(on) typical value, 2V: Input off threshold voltage Vth(off) typical value





FLAT-BASE TYPE INSULATED PACKAGE





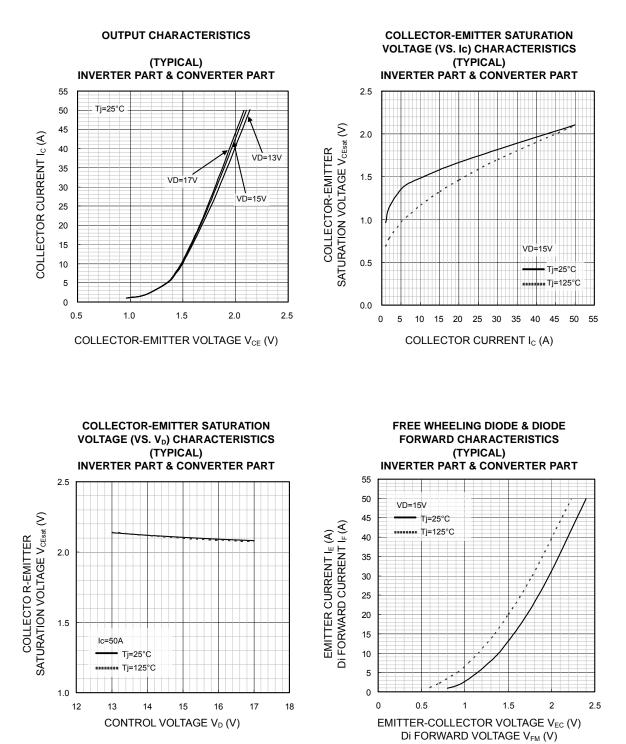
NOTES FOR STABLE AND SAFE OPERATION ;

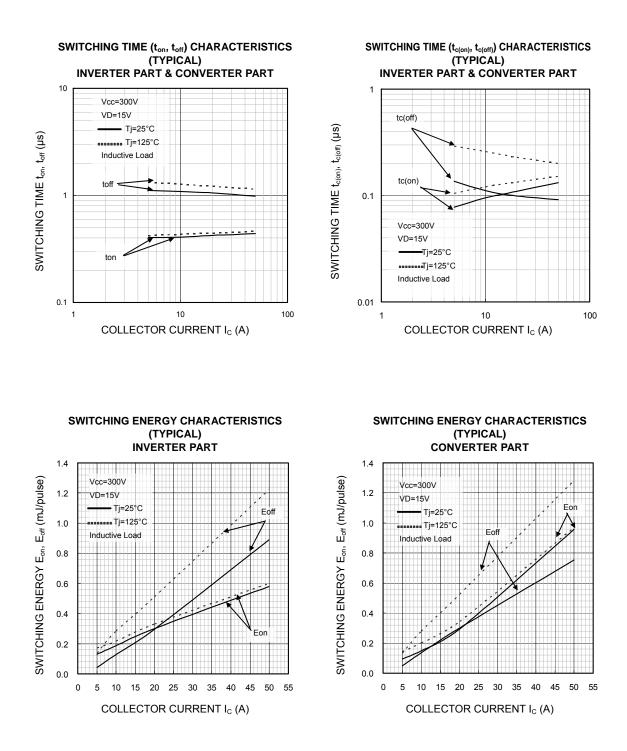
- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers: t_{PLH} , $t_{PHL} \le 0.8 \mu s$, Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- Use 3 isolated control power supplies (V_D). Also, care should be taken to minimize the instantaneous voltage charge of the power supply.
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.

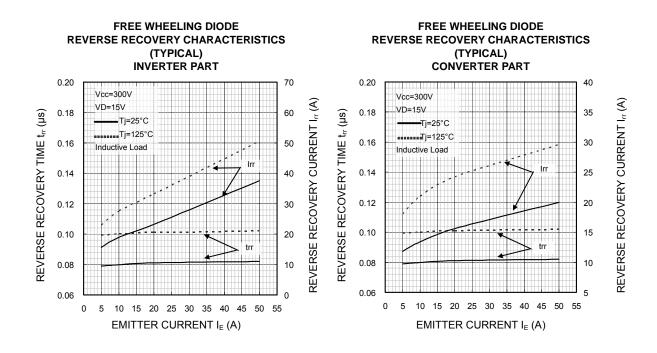


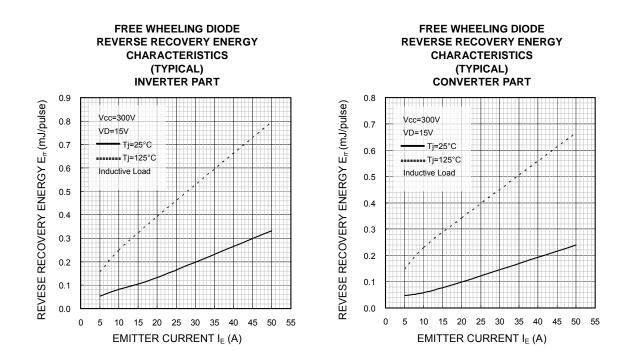
FLAT-BASE TYPE INSULATED PACKAGE

PERFORMANCE CURVES

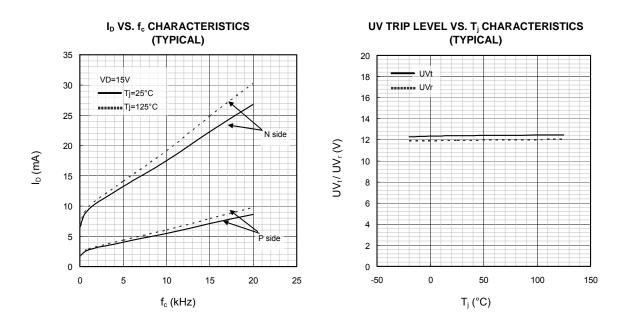


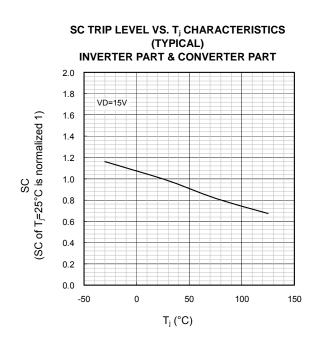




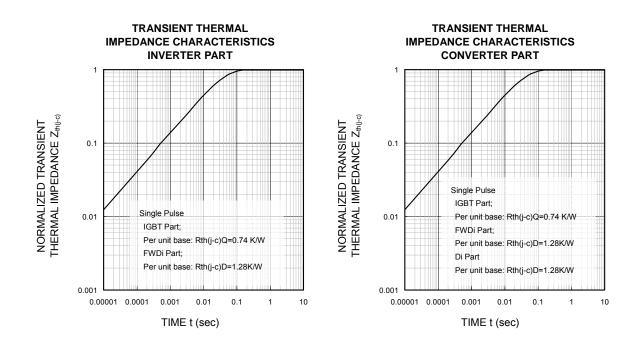














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